

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s) : TAKAGI, et al.

Int'l Appln. No. : PCT/JP01/03100

Int'l Filing Date : April 10, 2001

XX
Title of Invention : ASSET MANAGEMENT SYSTEM AND ASSET
MANAGEMENT METHOD

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Dear Sir:

Enclosed are copies of the publications which were cited in the International
Search Report of International Application No. PCT/JP01/03100. Also enclosed is a copy of
Form PTO-1449 and the International Search Report.

10/009152
JC10 Rec'd PCT/INT 06 DEC 2001
PATENT
450101-03306

REMARKS

Entry of this Information Disclosure Statement and an early examination on the
merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

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| Based on Form PTO-1449 (3/90) | | ATTY. DOCKET NO. 450101-03306 | SERIAL NO. To be assigned |
| LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary) | | APPLICANT TAKAGI, et al. | |
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U.S. PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
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FOREIGN PATENT DOCUMENTS

| | | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION | |
|--|----|-----------------|----------|---------|-------|----------|-------------|----|
| | | | | | | | YES | NO |
| | AK | 2000-224257 | 08/11/00 | Japan | | | | |
| | AL | 2001-502461 | 02/20/01 | Japan | | | | |
| | AM | 2001-75846 | 03/23/01 | Japan | | | | |
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